

# Device Modeling Report

COMPONENTS : VOLTAGE COMPARATOR  
PART NUMBER : LM319AJ  
MANUFACTURER : NATIONAL



**Bee Technologies Inc.**

## **BJT MODEL**

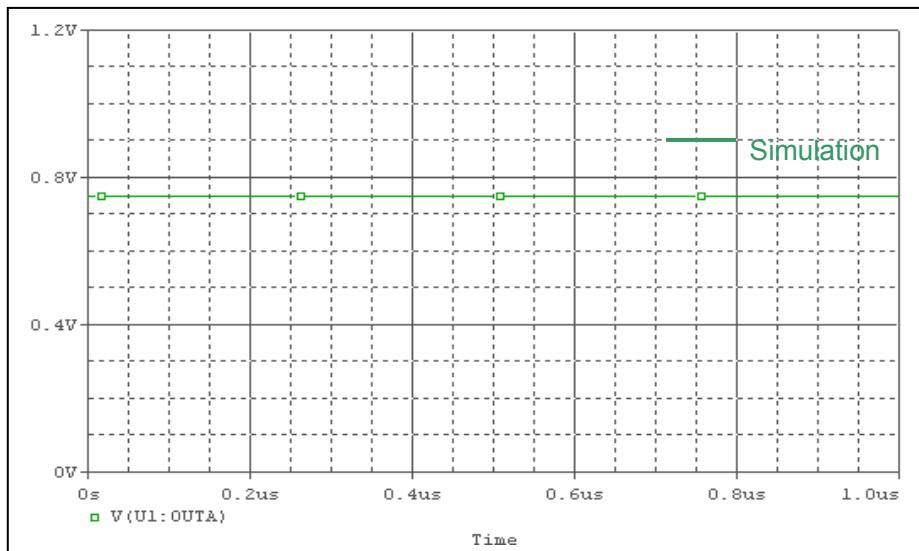
Pspice model parameter	Model description
IS	Saturation Current
BF	Ideal Maximum Forward Beta
CJC	Zero-bias Collector-Base Junction Capacitance
TF	Forward Transit Time
TR	Reverse Transit Time

## **DIODE MODEL**

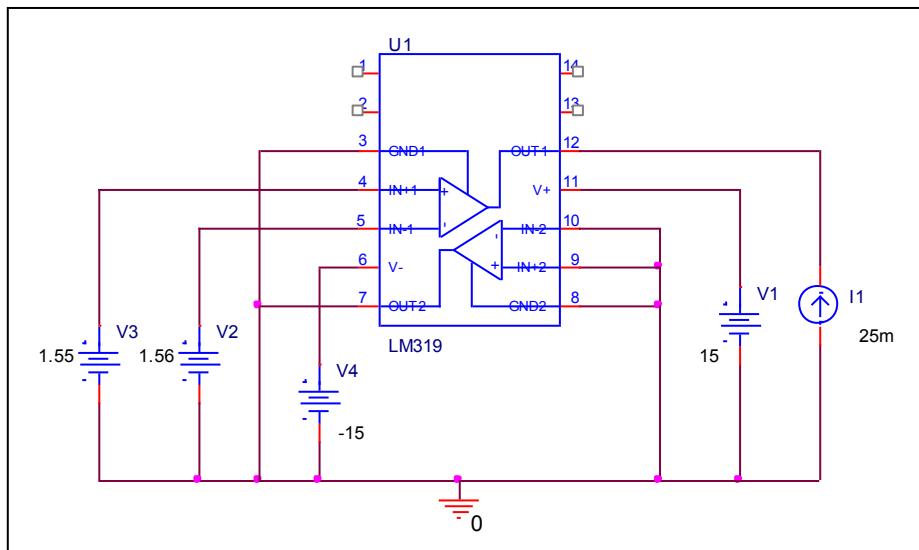
Pspice model parameter	Model description
IS	Saturation Current
RS	Series Resistance

## Output Low Voltage

Simulation result



Evaluation Circuit

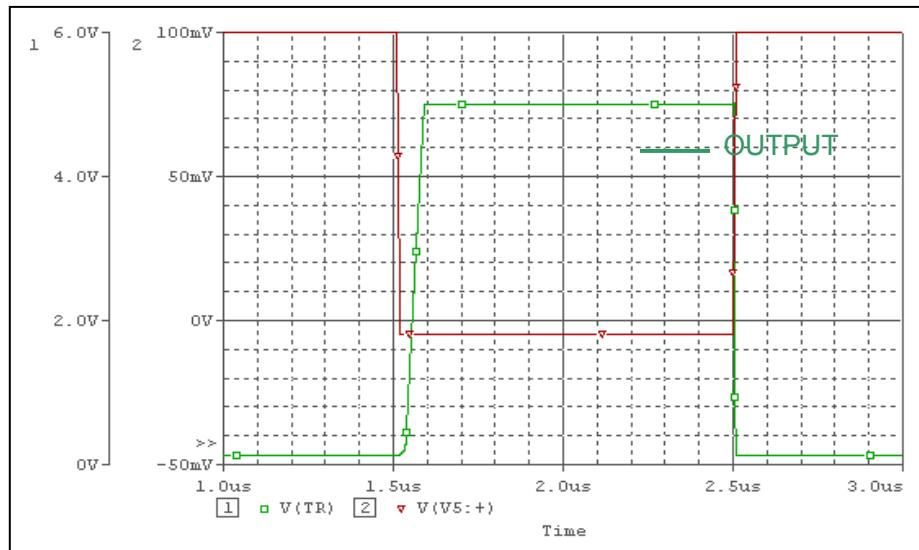


Comparison Table

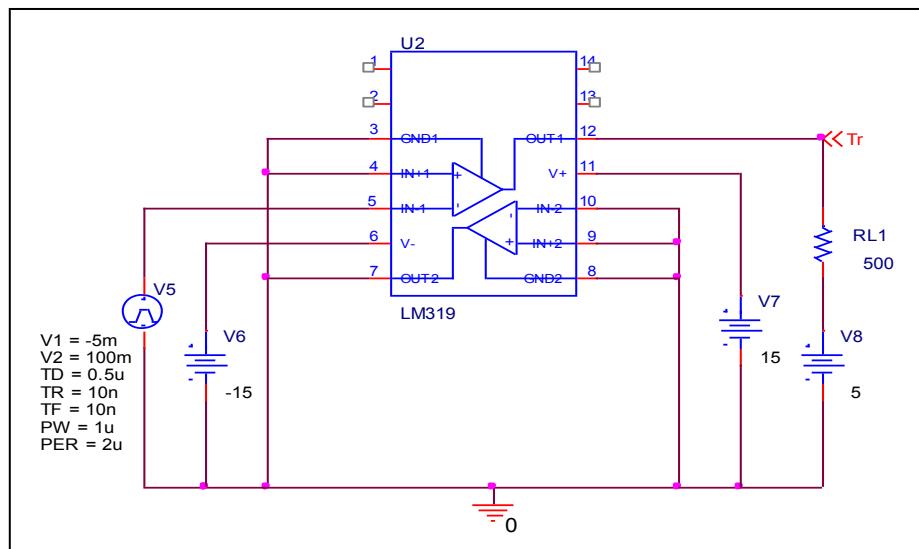
$I_o = 25\text{mA}$	Measurement	Simulation	%Error
$V_{ol} (\text{V})$	0.75	0.750832	0.111

## Response time (Rise time and Transition time)

Simulation result



Evaluation Circuit

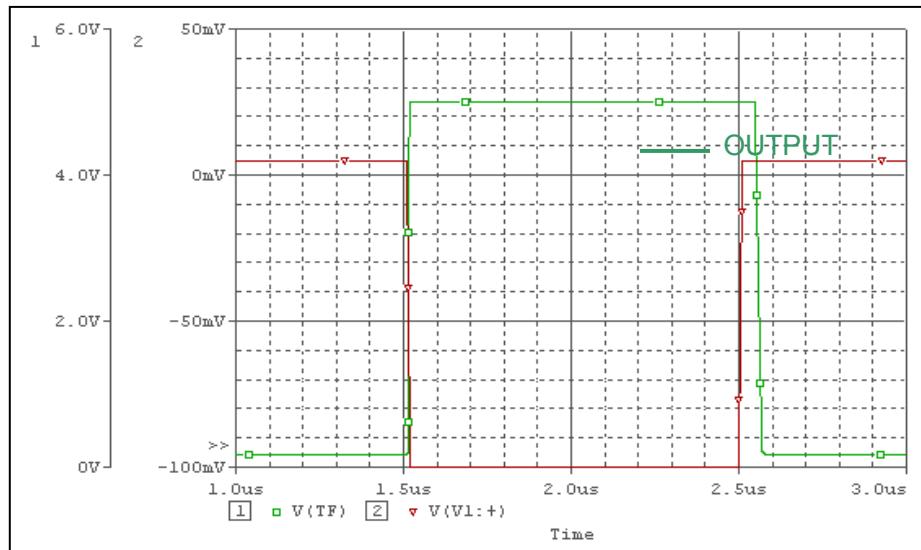


Comparison Table

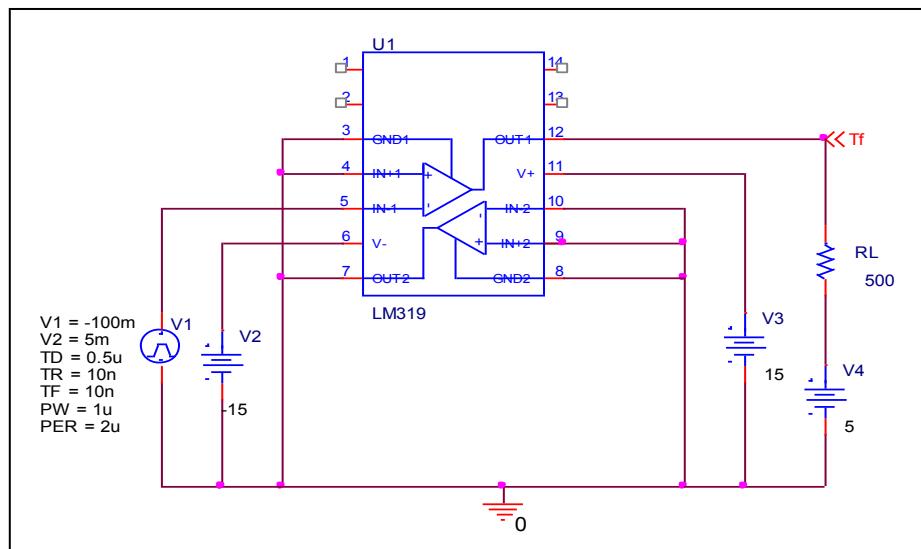
	Measurement	Simulation	% Error
Rising delay time (ns)	30	30.223	0.743
Transition time (ns)	45	44.559	-0.980

## Response time (Falling time)

Simulation result



Evaluation Circuit

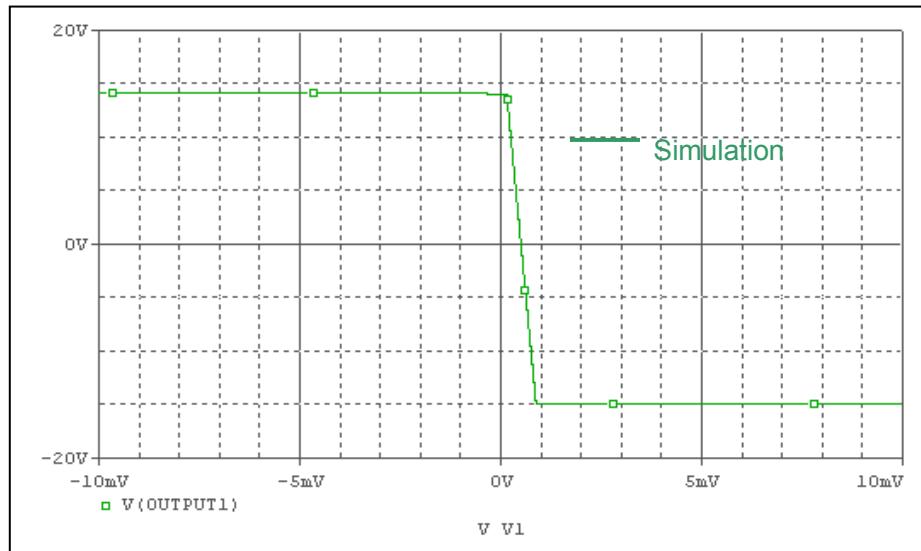


Comparison Table

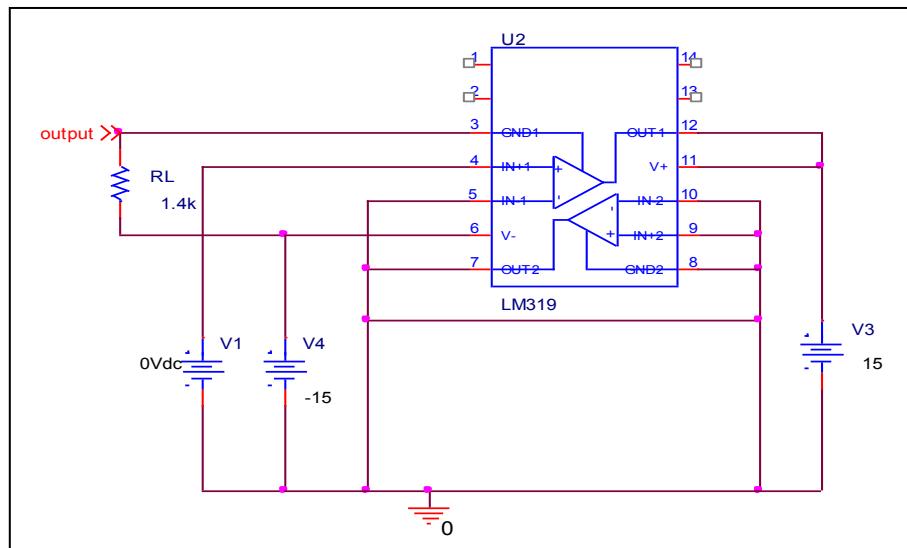
	Measurement	Simulation	% Error
Falling delay time (ns)	50	50.029	0.058

## Input Offset Voltage Characteristics

Simulation result



Evaluation Circuit

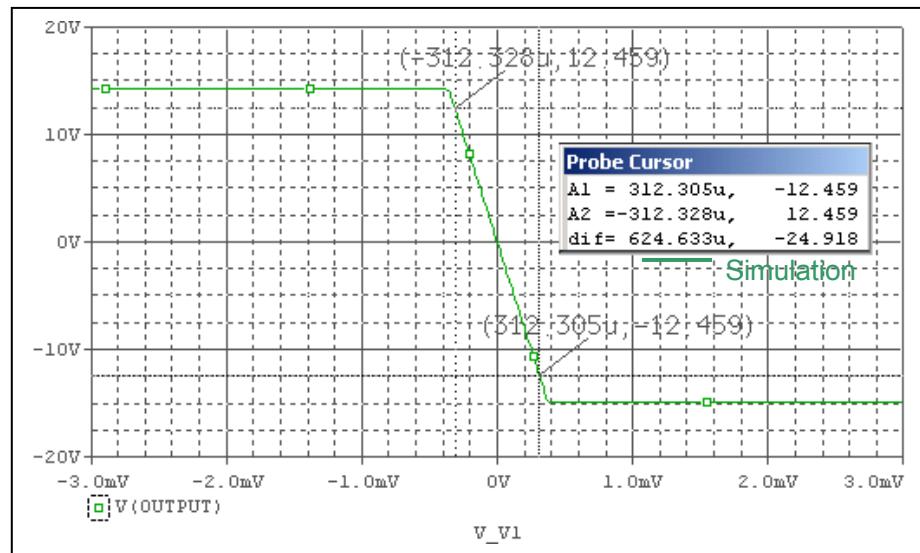


Comparison Table

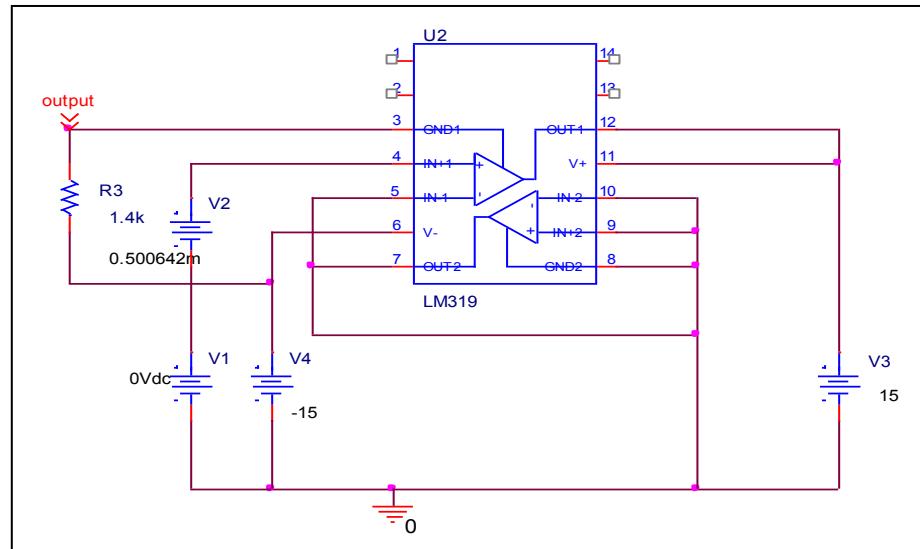
	Measurement	Simulation	%Error
$V_{io}(\text{mV})$	0.5	0.500642	0.128

## Av Characteristics

### Simulation result



### Evaluation Circuit



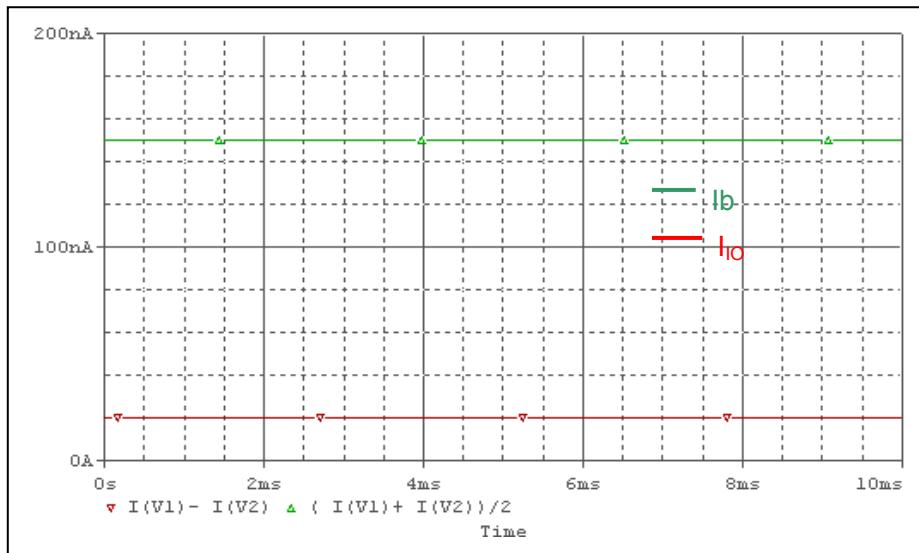
$$Av = 24.918 / 624.633 \mu$$

### Comparison Table

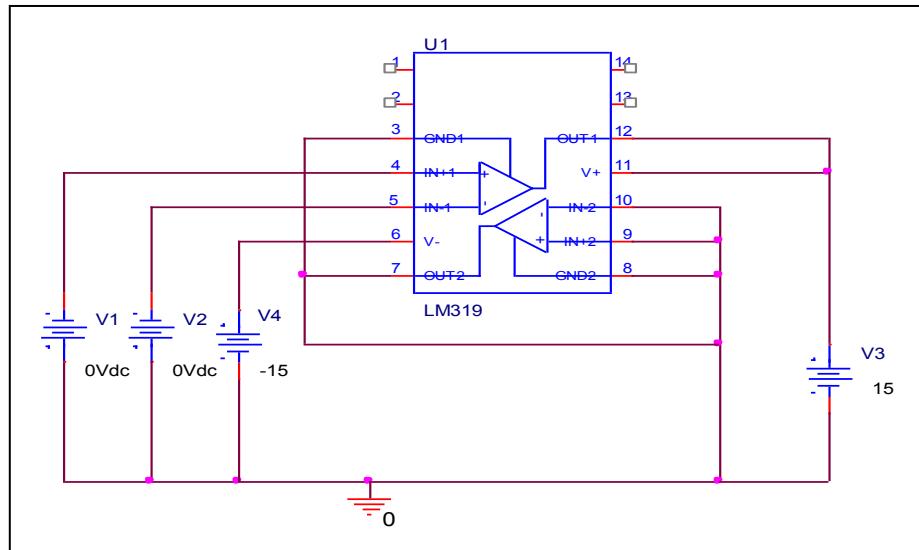
	Measurement	Simulation	%Error
Av (V/mV)	40	39.892	-0.270

## Input Bias Current Characteristics

Simulation result



Evaluation Circuit



Comparison Table

	Measurement	Simulation	% Error
$I_b$ (nA)	150	150.059	0.039
$I_{io}$ (nA)	20	19.952	-0.240